

Half-module 20

Half-module ID: 20

All test data and results

http://slac.stanford.edu/~meeg/SVT_production/half_module/20

Test 1

Test 2

Test 3

Half-module 20, test 3

Parameter	Value
ICAL	
ISHA	
VFP	
VFS	
Temperature	

Test data: http://slac.stanford.edu/~meeg/SVT_production/half_module/20/3/data
Test results (images and numerical values): http://slac.stanford.edu/~meeg/SVT_production/half_module/20/3/plots

Baseline run

Pedestal and noise (black markers are for all samples together, colored markers are individual samples)

Sample-to-sample shift

Noise correlations

Physical channel ordering:

PDF:

- http://slac.stanford.edu/~meeg/SVT_production/half_module/20/3/plots/hmodule20_pos_corr.pdf
- http://slac.stanford.edu/~meeg/SVT_production/half_module/20/3/plots/hmodule20_neg_corr.pdf

Readout channel ordering:

PDF:

- http://slac.stanford.edu/~meeg/SVT_production/half_module/20/3/plots/hmodule20_mux_pos_corr.pdf
- http://slac.stanford.edu/~meeg/SVT_production/half_module/20/3/plots/hmodule20_mux_neg_corr.pdf

Timing calibration runs, aggregate shaping curve fits

Fit parameters (colors identify calibration groups)

Timing calibration runs, hit-by-hit fits

Linearity of fitted T0 (ideal CR-RC fit on left, spline fit on right)

Goodness of fit (ideal CR-RC fit on left, spline fit on right)

Time resolution at each calibration delay (ideal CR-RC fit - stars mark error reported by fitter, dots mark spread in distribution of fitted values)

Time resolution at each calibration delay (spline fit - dots mark spread in distribution of fitted values, ignore stars as this fitter does not report fit errors)

Test 4

Test 5

Add test page ↗

Add short test page ↕